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CHO et al.(10) **Pub. No.: US 2011/0065234 A1**(43) **Pub. Date: Mar. 17, 2011**(54) **ORGANIC LIGHT EMITTING DISPLAY
DEVICE AND METHOD OF FABRICATING
THE SAME**(30) **Foreign Application Priority Data**

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CO., LTD.**, Yongin-city (KR)(57) **ABSTRACT**(21) Appl. No.: **12/897,104**

An organic light emitting display device and a method of fabricating the same are provided. The organic light emitting display device includes a substrate, a first electrode formed on the substrate, an inorganic pixel defining layer formed on the first electrode and having an opening exposing at least a portion of the first electrode, an organic layer disposed on the first electrode and having at least an organic emission layer, and a second electrode formed on the organic layer.

(22) Filed: **Oct. 4, 2010****Related U.S. Application Data**

(62) Division of application No. 11/209,839, filed on Aug. 24, 2005, now Pat. No. 7,829,890.

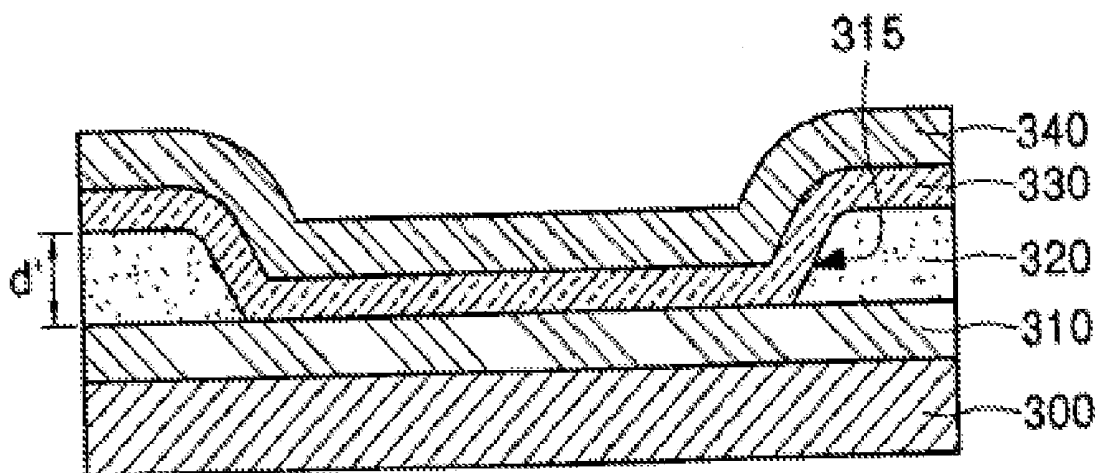


FIG. 1
(PRIOR ART)

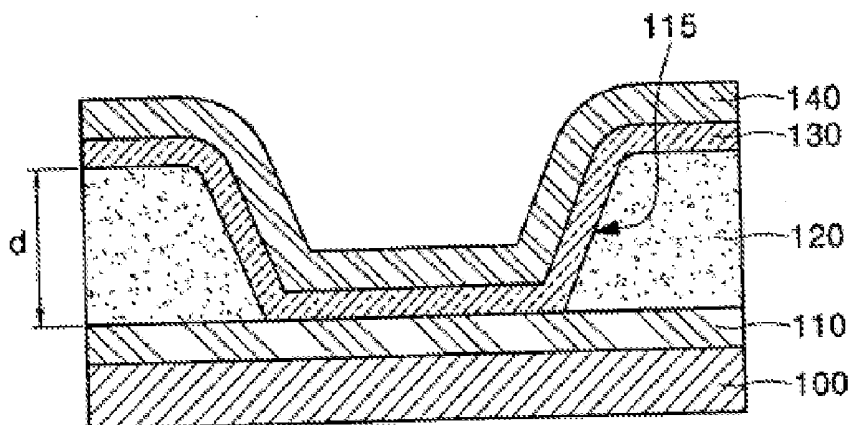
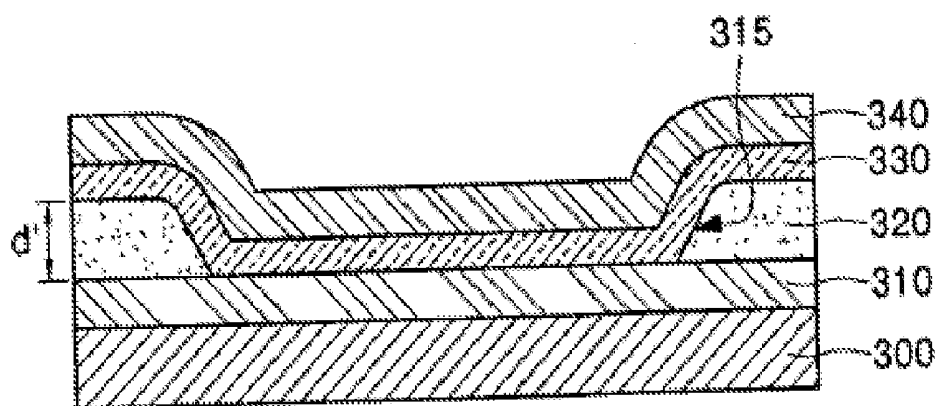


FIG. 2



**ORGANIC LIGHT EMITTING DISPLAY
DEVICE AND METHOD OF FABRICATING
THE SAME**

CROSS-REFERENCE TO RELATED
APPLICATIONS

[0001] This application is a divisional of U.S. application Ser. No. 11/209,839 filed Aug. 24, 2005, and claims priority from and the benefit of Korean Patent Application No. 10-2004-0067286, filed on Aug. 25, 2004, which are both hereby incorporated by reference for all purposes as if fully set forth herein.

BACKGROUND OF THE INVENTION

[0002] 1. Field of the Invention

[0003] The present invention relates to an organic light emitting display device (OLED) and a method of fabricating the same and, more particularly, to an organic light emitting display device including an inorganic pixel defining layer that prevents outgas from the pixel defining layer from deteriorating an organic emission layer.

[0004] 2. Discussion of the Background

[0005] Generally, an OLED is an emissive flat panel display device that electrically excites an organic compound to emit light. Hence, the OLED does not require a backlight unit, unlike a liquid crystal display (LCD). Therefore, the OLED may be made lightweight and thin using simplified processes. Also, the OLED may be fabricated at a low temperature, and it has a fast response speed of less than 1 ms, low power consumption, wide viewing angle, and high contrast. Accordingly, the OLED is attracting public attention as a next generation flat panel display device.

[0006] Generally, the OLED includes an organic emission layer between an anode and a cathode so that a hole supplied from the anode and an electron supplied from the cathode combine in the organic emission layer to form an exciton as a hole-electron pair, and the exciton returns to a ground state to generate energy, thereby emitting light.

[0007] An OLED may be a passive matrix or an active matrix OLED depending on how N×M pixels, disposed in a matrix, are driven. The passive matrix OLED has simpler manufacturing processes since its display region includes simple matrix type devices made of anodes and cathodes. However, its application may be limited to low resolution and small screen display devices due to problems of low resolution, high driving voltage, and reduced lifetime of the organic material. On the contrary, the active matrix OLED may be used for high resolution, large screen display devices since its display region includes thin film transistors formed in every pixel to supply a uniform current to the respective pixels to thereby obtain satisfactory brightness and low power consumption.

[0008] FIG. 1 is a cross-sectional view showing a pixel of a conventional OLED and a method of fabricating the same.

[0009] Referring to FIG. 1, a first electrode 110 is patterned and formed on a transparent substrate 100, which may be made of glass or plastic. When the first electrode 110 is an anode, it may be a transparent electrode made of indium tin oxide (ITO) or indium zinc oxide (IZO) having a high work function, or it may be a reflective electrode including a reflective layer made of a highly reflective metal such as Al, an Al alloy, or the like as its lower layer. When formed as a cathode, the first electrode 110 may be formed of a thin transparent

electrode made of one material selected from a group consisting of Mg, Ca, Al, Ag, and an alloy thereof as a conductive metal having a low work function, or it may be a thick reflective electrode.

[0010] A pixel defining layer 120, which defines a pixel region, is formed of an insulating material on the first electrode 110 in order to insulate an organic emission layer. Typically, the pixel defining layer 120 is formed of an organic material such as polyimide (PI), polyamide (PA), acryl resin, benzocyclobutene (BCB), and phenol resin.

[0011] The pixel defining layer 120 may be deposited on the substrate using a spin coating method. Referring to FIG. 1, the pixel defining layer 120 has a thickness d of about 1 μm to 2 μm.

[0012] An opening 115 is formed in the pixel defining layer 120 to expose a portion of a surface of the first electrode 110 using a dry etching process.

[0013] Then, an organic layer 130, including at least an organic emission layer, is formed on the pixel defining layer 120 and on the exposed first electrode 110. The organic layer 130 may further include at least one of a hole injection layer, a hole transport layer, a hole blocking layer, an electron transport layer, and an electron injection layer in addition to the organic emission layer. The organic emission layer may be made of a low molecular weight material such as, for example, aluminum-tris-quinolate (Alq3), anthracene, and cyclopentadiene, or a polymer material such as, for example, poly-(p-phenylenevinylene) (PPV) and its derivatives, polythiophene and its derivatives, and polyphenylene (PPP). The organic layer may be formed by a spin coating method and then patterned.

[0014] A second electrode 140 is formed on the entire surface of the organic layer 130. The second electrode 140 may be a reflective electrode made of one selected from a group consisting of Mg, Ca, Al, Ag and an alloy thereof, as a conductive metal having a low work function, when the first electrode 110 is a transparent anode or a transparent electrode including a reflective layer, and may be formed of a transparent electrode such as ITO or IZO when the first electrode 110 is a cathode. The second electrode 140 may be formed by a vacuum deposition method.

[0015] However, when the pixel defining layer 120 is formed of an organic material, outgassing of H₂O, O₂ and so on from the pixel defining layer into the organic layer 130 may deteriorate the organic layer 130, thereby increasing pixel shrinkage and decreasing the OLED's lifetime.

SUMMARY OF THE INVENTION

[0016] The present invention provides an organic light emitting display device including an inorganic pixel defining layer and a method of fabricating the same, in which it is possible to reduce pixel shrinkage and increase the lifetime of an organic emission layer.

[0017] Additional features of the invention will be set forth in the description which follows, and in part will be apparent from the description, or may be learned by practice of the invention.

[0018] The present invention discloses an organic light emitting display device including a substrate, a first electrode formed on the substrate, an inorganic pixel defining layer formed on the first electrode and having an opening for exposing at least a portion of the first electrode, an organic layer

disposed on the first electrode and having at least an organic emission layer, and a second electrode formed on the organic layer.

[0019] The present invention also discloses a method of fabricating an organic light emitting display device including forming a first electrode on a substrate, forming an inorganic pixel defining layer on the substrate having the first electrode, forming an opening in the inorganic pixel defining layer for exposing at least a portion of the first electrode, forming an organic layer having at least an organic emission layer on the exposed first electrode, and forming a second electrode on the organic layer. The inorganic pixel defining layer is formed by an annealing process after applying a solution using a coating method.

[0020] It is to be understood that both the foregoing general description and the following detailed description are exemplary and explanatory and are intended to provide further explanation of the invention as claimed.

BRIEF DESCRIPTION OF THE DRAWINGS

[0021] The accompanying drawings, which are included to provide a further understanding of the invention and are incorporated in and constitute a part of this specification, illustrate embodiments of the invention and together with the description serve to explain the principles of the invention.

[0022] FIG. 1 is a cross-sectional view showing a pixel of a conventional organic light emitting display device.

[0023] FIG. 2 is a cross-sectional view showing a pixel of an organic light emitting display device according to an embodiment of the present invention.

DETAILED DESCRIPTION OF THE ILLUSTRATED EMBODIMENTS

[0024] Referring to FIG. 2, in the OLED according to an embodiment of the present invention, a substrate 300 is provided, and a first electrode 310 is patterned and formed on the substrate 300. The substrate 300 may be a transparent insulating substrate such as glass, plastic, quartz, and so on.

[0025] When the first electrode 310 is an anode, it may be a transparent electrode made of ITO or IZO having a high work function, or it may be a reflective electrode including a reflective layer made of a highly reflective metal such as Al, an Al alloy, and so on as its lower layer.

[0026] If the first electrode 310 is a cathode, it may be formed of a thin transparent electrode made of one selected from a group consisting of Mg, Ca, Al, Ag, and an alloy thereof as a conductive metal material having a low work function, or it may be made of a thick reflective electrode.

[0027] An inorganic pixel defining layer 320 may be formed on the entire surface of the substrate including the first electrode 310. The inorganic pixel defining layer 320 is formed of an inorganic layer in order to prevent pixel shrinkage and decreased lifetime of the OLED, which are caused by deterioration of the organic emission layer due to outgassing of H₂O, O₂ and so on from the pixel defining layer made of a conventional organic layer. Forming the pixel defining layer of silicon oxide (SiO₂) or silicon on glass (SOG) may more effectively prevent outgassing.

[0028] In particular, when an organic layer 330 is formed on the inorganic pixel defining layer 320 by a laser induced thermal imaging (LITI) method, the inorganic pixel defining layer 320 may be formed of SOG having a small step formed therein.

[0029] When at least one layer of the organic layer 330 is formed using the LITI method, the step formed at a lower part affects transfer characteristics. When a transfer layer receives laser generated heat from a donor substrate including the transfer layer to be transferred to the substrate 300 of the OLED, if a lower structure has a large step, in particular, if the step is large at an edge portion of the inorganic pixel defining layer 320, the transfer layer, which is to be transferred, may be broken, which exposes the lower structure. Consequently, the first electrode 310 (a lower electrode) and a second electrode (upper electrode), which is formed after the organic layer 330, may contact each other, thereby generating a short circuit.

[0030] Therefore, since the inorganic pixel defining layer 320 should have a small step, forming the inorganic pixel defining layer 320 of the SOG makes it possible to maintain the small step. Here, the step should be about 500 nm high or less, preferably 200 nm.

[0031] The inorganic pixel defining layer 320 includes an opening 315 for exposing at least a portion of an upper surface of the first electrode 310.

[0032] The inorganic pixel defining layer 320 may have a thickness d' of about 1,000 to about 10,000 Å in order to function as an insulating layer separating a pixel region and to prevent cracks from generating due to stress during the annealing process. As a result, when the organic layer 330 is subsequently deposited on the first electrode 310 using the LITI method, it is possible to prevent the organic layer from breaking because the organic layer typically broke due to a step generated by the 1 to 2 μm thick conventional pixel defining layer. Further, adhesion between the first electrode and the organic layer may be improved. At this time, the pixel defining layer 320 allows a greater portion of the first electrode 310 to be exposed, thereby increasing an aperture ratio of the OLED.

[0033] An organic layer 330, including at least an organic emission layer, is formed on the first electrode 310 through the opening 315. The organic layer may further include at least one of a hole injection layer, a hole transport layer, a hole blocking layer, an electron transport layer and an electron injection layer in addition to the organic emission layer.

[0034] A second electrode 340 is formed on the organic layer 330.

[0035] The second electrode 340 may be a reflective electrode made of one selected from a group consisting of Mg, Ca, Al, Ag and an alloy thereof, as a conductive metal material having a low work function, when the first electrode 310 is a transparent anode or a transparent electrode including a reflective layer, and may be formed of a transparent electrode such as ITO or IZO when the first electrode 310 is a cathode.

[0036] Hereinafter, a method of fabricating an organic light emitting display device will be described.

[0037] Referring to FIG. 2, a substrate 300 is provided. The substrate 300 may be a transparent insulating substrate such as glass, plastic, quartz and so on.

[0038] Next, a first electrode 310 is formed on the substrate 300.

[0039] The first electrode 310 may be deposited by a sputtering or ion plating method. For example, the first electrode 310 is formed by depositing using a sputtering method and then selectively patterned through a wet etching method using a photoresist (PR), patterned during a photolithography process, as a mask.

[0040] An inorganic pixel defining layer 320 may be formed on the entire surface of the substrate including the first

electrode 310. The inorganic pixel defining layer 320 is formed of an inorganic material as an inorganic insulating layer for defining a unit pixel region. For example, the inorganic pixel defining layer 320 may be formed of SiO₂ or SOG.

[0041] In an embodiment of the present invention, the inorganic pixel defining layer 320 is formed of a solution of methyl siloxane 10 wt %~20 wt % dissolved in propylene glycol monomethyl ether acetate (PGMEA) solvent or a solution of hydrogen silsesquioxane (HSQ) 5 wt %~35 wt % dissolved in PGMEA solvent.

[0042] The inorganic pixel defining layer 320 may be formed on the substrate through a high temperature annealing process after coating the solution on the first electrode 310.

[0043] For example, the inorganic pixel defining layer 320 may be formed by applying the solution on the substrate using a spin coating method. A lower step of the substrate is compensated by the applied solution.

[0044] The solution applied on the substrate forms a substantially uniform layer having a thickness of about 1,000 to about 10,000 Å by operating a coating apparatus for about 1 to about 30 seconds at a spin speed of about 100 to about 1300 rpm.

[0045] Since the pixel defining layer 320 may be about 20,000 Å thick or more when the spin speed of the coating apparatus is 1 second or more at 100 rpm or less, and the pixel defining layer 320 may be about 1,000 Å thick or less when the spin speed is 30 seconds or less at 1300 rpm or more,

substrate. Hence, the annealing temperature should maintain a range of about 200 to about 300° C.

[0048] Since the layer is insufficiently formed when the annealing process is ½ hour or less, and the layer is sufficiently formed by about 1 hour, preferably, the annealing process should be performed for about ½ hour to about 1 hour.

[0049] H₂O contained in the applied layer is removed through the high temperature annealing process to finally form the pixel defining layer 320 made of SiO₂.

[0050] Hereinafter, a reaction mechanism that the inorganic pixel defining layer is formed of SiO₂ will be described.

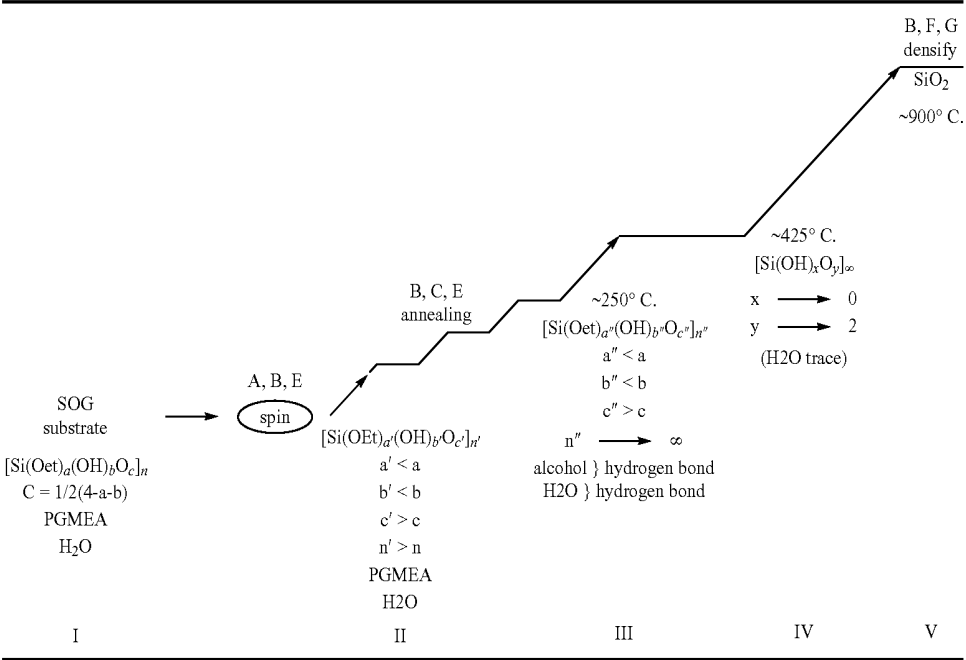
[0051] Table 1 represents physical/chemical variations for understanding of an SiO₂ forming mechanism.

TABLE 1

Symbol	Title	Reaction formula
A	Hydrolysis	$\text{Si-OEt} + \text{H}_2\text{O} \rightarrow \text{Si-OH}$
B	Condensation	$\text{Si-OH} + \text{HO-Si} \rightarrow \text{Si-O-Si}$
C	Condensation	$\text{Si-OEt} + \text{HO-Si} \rightarrow \text{Si-O-Si}$
D	Decomposition	$\text{Si-OEt} \rightarrow \text{Si-OH}$
E	Evaporation	
F	Dehydration	
G	Viscous sintering	

[0052] Table 2 represents an SiO₂ forming reaction mechanism.

TABLE 2



preferably, the spin speed should be maintained at about 100 to about 1300 rpm for about 1 to about 30 seconds.

[0046] The solution applied on the substrate is annealed at a temperature of about 200 to about 300° C. for about ½ hour to about 1 hour.

[0047] The layer formed of the solution may be cured at temperatures of 200° C. and above, but a temperature greater than 300° C. exceeds a glass transition temperature of the

[0053] Referring to Table 2, the reaction mechanism will be described in steps I through V.

[0054] Step I—solution of methyl siloxane 10~20 wt % dissolved in PGMEA solvent or solution of HSQ 5~35 wt % dissolved in PGMEA solvent is prepared.

[0055] In this process, $[\text{Si}(\text{Oet})_a(\text{OH})_b\text{O}_c]_n$, solvent (PGMEA), and H_2O are prepared.

[0056] Where, $c=1/2(4-a-b)$ (a, b, c, n are integers).

[0057] Step II—the solution in step I is applied on the substrate using a spin coating method.

[0058] This process includes A, B and E reactions to generate $[\text{Si}(\text{OEt})\text{a}'(\text{OH})\text{b}'\text{Oc}']\text{n}'$, and solvent (PGMEA) and H_2O exist. At this time, relationships of $\text{a}' < \text{a}$, $\text{b}' < \text{b}$, $\text{c}' > \text{c}$, and $\text{n}' > \text{n}$ are satisfied (a' , b' , c' , n' are integers).

[0059] Step III—a material generated in step II is annealed.

[0060] This process includes B, C and E reactions at a temperature of about 250°C . or less to generate $[\text{Si}(\text{Oet})\text{a}''(\text{OH})\text{b}''\text{Oc}'']\text{n}''$. At this time, relationships of $\text{a}'' < \text{a}'$, $\text{b}'' < \text{b}'$, $\text{c}'' > \text{c}'$, and $\text{n}'' \rightarrow \infty$ are satisfied, and the generated material contains alcohol, H_2O and hydrogen bond (a' , b' , c' , n' are integers).

[0061] Step IV—the material generated in step III generates $[\text{Si}(\text{OH})\text{xOy}]\infty$ at a temperature of about 425°C . or less.

[0062] At this time, $\text{x} \rightarrow 0$, $\text{y} \rightarrow 42$, and trace H_2O .

[0063] Step V—the material generated in step IV includes B, F and G reactions at a temperature of about 900°C . or less to form SiO_2 as a final product of the reaction.

[0064] While the reaction mechanism forms the SiO_2 layer at a high temperature of about 900°C . or less, the substrate of the present invention has a glass transition temperature T_g of about 250 to about 300°C . Since a low molecular weight material such as aluminum-tris-quinolate (Alq3) used as a material for the organic emission layer has low thermal stability, it is preferable to form the SiO_2 layer through the annealing process at a temperature of about 300°C . or less.

[0065] As a result of measuring a contact angle of a material generated at a temperature of about 200 to about 300°C . by the reaction mechanism in an embodiment of the present invention, the material has the same contact angle, i.e., 30° as the silicon oxide SiO_2 layer generated at the temperature of about 900°C . Therefore, the generated material of the present invention is the substantially the same material as the SiO_2 layer.

[0066] An inorganic pixel defining layer 320 having an opening 315 for exposing a portion of a surface of the first electrode 310 may be formed by a dry etching process using a photoresist pattern.

[0067] Portions of the inorganic pixel defining layer 320 are selectively removed during the etching process, using the photoresist pattern formed by the photograph process, to transfer a pattern designed in a reticle to the substrate. The etching process provides the thin layer with a smooth etching profile. For example, the dry etching process may include performing plasma discharge in a chamber having a certain pressure to decompose the reaction gas into ions, radicals, electrons and so on. At this time, the generated radicals cause chemical reaction to perform etching, i.e., plasma etching. The plasma etching process may use CF_4 as an etchant.

[0068] After the dry etching process, a photoresist strip process and a cleaning process are performed to remove the photoresist. The photoresist strip process may be performed using a high concentration of alkali solution, and the cleaning process may be performed through plasma treatment.

[0069] An organic layer 330, including at least an organic emission layer, is then formed on the entire surface of the substrate including the exposed first electrode 310. The organic layer 330 may be formed by a LITI method when a lower inorganic pixel defining layer 320 is formed of silicon on glass (SOG).

[0070] The organic emission layer 330 may be made of a low molecular weight material or a polymer material. For example, the low molecular weight material may be one

selected from a group consisting of Alq3, anthracene, cyclopentadiene, BeBp2, Almq, ZnPBO, Balq, DPVBi, BSA-2 and 2PSP.

[0071] For example, the polymer material may be one selected from a group consisting of poly(p-phenylenevinylene) (PPV) and its derivatives, polythiophene (PT) and its derivatives, and polyphenylene (PPP) and its derivatives.

[0072] The organic layer 330 may be deposited using a vacuum deposition method, a spin coating method, an inkjet printing method, a doctor blade method, a LITI method, and so forth. Additionally, a thinner inorganic pixel defining layer 320 decreases a step between the first electrode 310 and the inorganic pixel defining layer 320, thereby allowing the organic layer 330 to be formed using the LITI method.

[0073] Each unit pixel may be individually patterned to form the organic layer 330. The organic layer 330 may be patterned using the LITI method and the vacuum deposition method using a shadow mask.

[0074] Next, a second electrode 340 is formed on the entire surface of the organic layer 330. The second electrode 340 may be formed by vacuum deposition.

[0075] As described above, when an inorganic layer is used as the pixel defining layer, the inorganic pixel defining layer 320 formed of silicon oxide prevents outgassing of H_2O , O_2 and so on from the pixel defining layer into the organic layer 330 to prevent the organic layer from deteriorating, thereby improving pixel shrinkage and lifetime of the organic emission layer.

[0076] As discussed above, exemplary embodiments of the present invention may improve pixel shrinkage and lifetime of an organic emission layer by forming an inorganic pixel defining layer made of silicon oxide (SiO_2) using a coating process and a high temperature annealing process to prevent outgassing of H_2O , O_2 and so on from the pixel defining layer, thereby preventing the organic emission layer from deteriorating.

[0077] Additionally, it is possible to improve an aperture ratio by increasing a pixel opening region through compensation of a lower step using the solution, to prevent the organic layer from being shorted due to the lower step when the organic layer is deposited by the LITI method on the first electrode by forming the inorganic pixel defining layer about $1,000$ to about $10,000\text{ \AA}$ thick, and to improve adhesion between the first electrode and the organic layer.

[0078] It will be apparent to those skilled in the art that various modifications and variation can be made in the present invention without departing from the spirit or scope of the invention. Thus, it is intended that the present invention cover the modifications and variations of this invention provided they come within the scope of the appended claims and their equivalents.

What is claimed is:

1. A method of fabricating an organic light emitting display device, comprising:

- forming a first electrode on a substrate;
- forming an inorganic pixel defining layer on the substrate having the first electrode;
- forming an opening in the inorganic pixel defining layer for exposing at least a portion of the first electrode;
- forming an organic layer having at least an organic emission layer on the first electrode; and
- forming a second electrode on the organic layer,

wherein the inorganic pixel defining layer is formed by an annealing process after applying a solution using a coating method.

2. The method of claim 1, wherein the inorganic pixel defining layer is formed of a silicon oxide (SiO_2) layer.

3. The method of claim 1, wherein the inorganic pixel defining layer is formed using a solution of methyl siloxane dissolved in propylene glycol monomethyl ether acetate (PGMEA) solvent or a solution of hydrogen silsesquioxane (HSQ) dissolved in PGMEA solvent.

4. The method of claim 3, wherein the solution is a solution of methyl siloxane 10 wt %~20 wt % dissolved in PGMEA solvent or a solution of HSQ 5 wt %~35 wt % dissolved in PGMEA solvent.

5. The method of claim 1, wherein the coating method is performed at a spin speed of about 10 rpm to about 1,300 rpm for about 1 second to about 30 seconds.

6. The method of claim 1, wherein the inorganic pixel defining layer is about 1,000 Å to about 10,000 Å thick.

7. The method of claim 1, wherein the inorganic pixel defining layer is annealed at a temperature of about 200° C. to about 300° C.

8. The method of claim 1, wherein the annealing process is performed for about 30 minutes to about 1 hour.

9. The method of claim 1, wherein the inorganic pixel defining layer is formed of a silicon oxide (SiO_2) layer by removing H_2O contained in the silicon oxide (SiO_2) layer through an annealing process.

10. The method of claim 1, wherein the opening of the inorganic pixel defining layer is formed by a dry etching process.

11. The method of claim 10, wherein the dry etching process is performed using a plasma etching method.

12. The method of claim 1, wherein the inorganic pixel defining layer is made of silicon on glass (SOG), and wherein the inorganic pixel defining layer is formed by an annealing process after applying a solution using a coating method.

13. The method of claim 12, wherein the inorganic pixel defining layer is formed using a solution of methyl siloxane dissolved in propylene glycol monomethyl ether acetate (PGMEA) solvent or a solution of hydrogen silsesquioxane (HSQ) dissolved in PGMEA solvent.

14. The method of claim 13, wherein the solution is a solution of methyl siloxane 10 wt %~20 wt % dissolved in PGMEA solvent or a solution of HSQ 5 wt %~35 wt % dissolved in PGMEA solvent.

15. The method of claim 12, wherein the coating method is performed at a spin speed of about 10 rpm to about 1,300 rpm for about 1 second to about 30 seconds.

16. The method of claim 12, wherein the inorganic pixel defining layer is annealed at a temperature of about 200° C. to about 300° C.

17. The method of claim 12, wherein the annealing process is performed for about 30 minutes to about 1 hour.

18. The method of claim 12, wherein the opening of the inorganic pixel defining layer is formed by a dry etching process.

19. The method of claim 18, wherein the dry etching process is performed using a plasma etching method.

* * * * *

专利名称(译)	有机发光显示装置及其制造方法		
公开(公告)号	US20110065234A1	公开(公告)日	2011-03-17
申请号	US12/897104	申请日	2010-10-04
[标]申请(专利权)人(译)	三星显示有限公司		
申请(专利权)人(译)	三星移动显示器有限公司.		
当前申请(专利权)人(译)	三星DISPLAY CO. , LTD.		
[标]发明人	CHO YU SUNG KANG HO JIN OH MYUNG HO		
发明人	CHO, YU-SUNG KANG, HO-JIN OH, MYUNG-HO		
IPC分类号	H01L51/40		
CPC分类号	H01L21/316 H01L2251/558 H01L27/3283 H01L27/3246 H01L21/02164		
优先权	1020040067286 2004-08-25 KR		
其他公开文献	US8334168		
外部链接	Espacenet USPTO		

摘要(译)

提供一种有机发光显示装置及其制造方法。有机发光显示装置包括基板，形成在基板上的第一电极，形成在第一电极上并具有暴露第一电极的至少一部分的开口的无机像素限定层，设置在第一电极上的有机层至少具有有机发光层，和在有机层上形成的第二电极。

